INTEGRATED CIRCUITS

DATA SHEET

SA7016

1.3GHz low voltage fractional-N synthesizer

Product specification Supersedes data of 1998 Oct 16





1.3GHz low voltage fractional-N synthesizer

SA7016

GENERAL DESCRIPTION

The SA7016 BICMOS device integrates programmable dividers, charge pumps and a phase comparator to implement a phase-locked loop. The device is designed to operate from 3 NiCd cells, in pocket phones, with low current and nominal 3 V supplies.

The synthesizer operates at VCO input frequencies up to 1.3 GHz. The synthesizer has fully programmable main and reference dividers. All divider ratios are supplied via a 3-wire serial programming bus.

Separate power and ground pins are provided to the analog and digital circuits. The ground leads should be externally short-circuited to prevent large currents flowing across the die and thus causing damage. V_{DDCP} must be greater than or equal to V_{DD}.

The charge pump current (gain) is set by an external resistance at the RSET pin. Only passive loop filters could be used; the charge pump operates within a wide voltage compliance range to provide a wider tuning range.

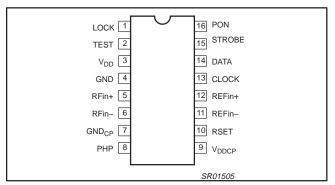


Figure 1. Pin Configuration

FEATURES

- Low phase noise
- Low power
- Fully programmable main divider
- Internal fractional spurious compensation
- Hardware and software power down
- Split supply for V_{DD} and V_{DDCP}

APPLICATIONS

- 350-1300 MHz wireless equipment
- Cellular phones
- Portable battery-powered radio equipment.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{DD}	Supply voltage		2.7	-	5.5	٧
V _{DDCP}	Analog supply voltage	$V_{DDCP} \ge V_{DD}$	2.7	-	5.5	٧
I _{DDCP} +I _{DD}	Supply current		-	6.2	7.3	mA
I _{DDCP} +I _{DD}	Total supply current in power-down mode		-	1	-	μΑ
f _{VCO}	Input frequency		350	-	1300	MHz
f _{REF}	Crystal reference input frequency		5	-	40	MHz
f _{PC}	Maximum phase comparator frequency		-		4	MHz
T _A	Operating ambient temperature		-40	_	+85	°C

ORDERING INFORMATION

TYPE NUMBER	PACKAGE						
TIPE NOWBER	NAME	DESCRIPTION	VERSION				
SA7016	TSSOP16	Plastic thin shrink small outline package; 16 leads; body width 4.4 mm					

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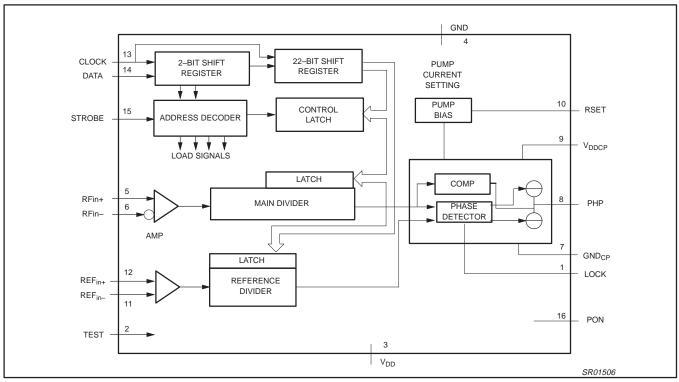


Figure 2. Block Diagram

PINNING

SYMBOL	PIN	DESCRIPTION
LOCK	1	Lock detect output
TEST	2	Test (should be either grounded or connected to V _{DD)}
V_{DD}	3	Digital supply
GND	4	Digital ground
RFin+	5	RF input to main divider
RFin-	6	RF input to main divider
GND _{CP}	7	Charge pump ground
PHP	8	Main normal chargepump
V _{DDCP}	9	Charge pump supply voltage
RSET	10	External resistor from this pin to ground sets the chargepump current
REFin-	11	Reference input
REFin+	12	Reference input
CLOCK	13	Programming bus clock input
DATA	14	Programming bus data input
STROBE	15	Programming bus enable input
PON	16	Power down control

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V _{DD}	Digital supply voltage	-0.3	+5.5	V
V _{DDCP}	Analog supply voltage	-0.3	+5.5	V
$\Delta V_{DDCP} - V_{DD}$	Difference in voltage between $V_{DDCP \text{ and }} V_{DD} (V_{DDCP} \ge V_{DD})$	-0.3	+2.8	V
V _n	Voltage at pins 1, 2, 5, 6, 11 to 16	-0.3	V _{DD} + 0.3	V
V ₁	Voltage at pin 8, 9	-0.3	V _{DDCP} + 0.3	V
ΔV_{GND}	Difference in voltage between GND _{CP} and GND (these pins should be connected together)	-0.3	+0.3	V
T _{stg}	Storage temperature	- 55	+125	°C
T _A	Operating ambient temperature	-40	+85	°C
Tj	Maximum junction temperature		150	°C

Handling

Inputs and outputs are protected against electrostatic discharge in normal handling. However, to be totally safe, it is desirable to take normal precautions appropriate to handling MOS devices.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th j–a}	Thermal resistance from junction to ambient in free air	120	K/W

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CHARACTERISTICS

 V_{DDCP} = V_{DD} = +3.0V, T_A = +25°C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply; pin	s 3, 9	-				
V_{DD}	Digital supply voltage		2.7	-	5.5	٧
V _{DDCP}	Analog supply voltage	$V_{DDCP} = V_{DD}$	2.7	-	5.5	٧
I _{DDTotal}	Synthesizer operational digital supply current	V _{DD} = +3.0V	-	6.2	7.3	mA
I _{Standby}	Total supply current in power-down mode	logic levels 0 or VDD	_	1	TBD	μΑ
RFin main	divider input; pins 5, 6	-				
f_{VCO}	VCO input frequency		350	-	1300	MHz
V _{RFin(rms)}	AC-coupled input signal level	R_{in} (external) = R_s = 50Ω ; single-ended drive; max. limit is indicative @ 500 to 1300 MHz	-18	-	0	dBm
Z _{IRFin}	Input impedance (real part)	f _{VCO} = 1.2 GHz	_	625	-	Ω
C _{IRFin}	Typical pin input capacitance	f _{VCO} = 1.2 GHz	_	1.0	_	pF
N _{main}	Main divider ratio		512	-	65535	
f _{PCmax}	Maximum loop comparison frequency	indicative, not tested	_	-	4	MHz
Reference	divider input; pins 11, 12					
f _{REFin}	Input frequency range from TCXO		5	-	40	MHz
VRFin	AC-coupled input signal level	single-ended drive; max. limit is indicative	360	-	1300	mV_{PP}
Z _{REFin}	Input impedance (real part)	f _{REF} = 20 MHz	-	10	-	kΩ
C _{REFin}	Typical pin input capacitance	f _{REF} = 20 MHz	_	1.0	-	pF
R _{REF}	Reference division ratio		4	-	1023	
Charge pur	np current setting resistor input; pin 10					
R _{SET}	External resistor from pin to ground		6	7.5	15	kΩ
V _{SET}	Regulated voltage at pin	R _{SET} =7.5 kΩ	-	1.25	-	٧
Charge pur	np outputs (including fractional compensation pu	ump); pin 8; R_{SET} =7.5 $k\Omega$, FC	C=80			
I _{CP}	Charge pump current ratio to I _{SET} ¹	Current gain I _{PH} /I _{SET}	-15		+15	%
I _{MATCH}	Sink-to-source current matching	V _{PH} =1/2 V _{DDCP} .	-10		+10	%
I _{ZOUT}	Output current variation versus V _{PH} ²	V _{PH} in compliance range	-10		+10	%
I _{LPH}	Charge pump off leakage current	V _{PH} =1/2 V _{CC}	-10		+10	nA
V_{PH}	Charge pump voltage compliance		0.7	-	V _{DDCP} -0.8	٧
Phase nois	e (R _{SET} = 7.5 kΩ, CP=00)					
C/N	Synthesizer's contribution to close-in phase noise of 800 MHz RF signal at 1 kHz offset.	f _{REF} = 19.44MHz, TCXO,	_	-85	-	dBc/Hz
C/N	Synthesizer's contribution to close-in phase noise of 960 MHz RF signal at 1 kHz offset.	f _{COMP} = 240kHz indicative, not tested	-	-84	-	dBc/Hz
Interface lo	gic input signal levels; pins 13, 14, 15, 16				•	•
V _{IH}	HIGH level input voltage		0.7*V _{DD}	-	V _{DD} +0.3	٧
V _{IL}	LOW level input voltage		-0.3	-	0.3*V _{DD}	٧
I _{LEAK}	Input leakage current	logic 1 or logic 0	-0.5	_	+0.5	μΑ

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Lock detect	output signal (in push/pull mode); pin 1					
V _{OL}	LOW level output voltage	I _{sink} =2mA	-	-	0.4	V
V _{OH}	HIGH level output voltage	I _{source} =-2mA	V _{DD} -0.4	-	-	V

NOTES:

1. $I_{SET} = \frac{V_{SET}}{R_{SET}}$ bias current for charge pumps.

2. The relative output current variation is defined as:

$$\frac{\Delta I_{OUT}}{I_{OUT}} = 2 \cdot \frac{(I_2 - I_1)}{I(I_2 + I_1)I}; \text{ with } V_1 = 0.7V, \ V_2 = V_{DDCP} - 0.8V \text{ (See Figure 3.)}$$

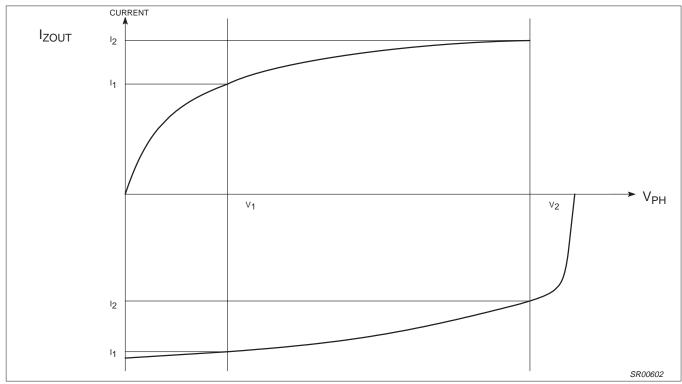


Figure 3. Relative Output Current Variation

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FUNCTIONAL DESCRIPTION

Main Fractional-N divider

The RFin inputs drive a pre-amplifier to provide the clock to the first divider stage. For single ended operation, the signal should be fed to one of the inputs while the other one is AC grounded. The pre-amplifier has a high input impedance, dominated by pin and pad capacitance. The circuit operates with signal levels from –18dBm to 0dBm, and at frequencies as high as 2.5 GHz. The divider consists of a fully programmable bipolar prescaler followed by a CMOS counter. Total divide ratios range from 512 to 65536.

At the completion of a main divider cycle, a main divider output pulse is generated which will drive the main phase comparator. Also, the fractional accumulator is incremented by the value of NF. The accumulator works with modulo Q set by FMOD. When the accumulator overflows, the overall division ratio N will be increased by 1 to N + 1, the average division ratio over Q main divider cycles (either 5 or 8) will be

$$Nfrac = N + \frac{NF}{O}$$

The output of the main divider will be modulated with a fractional phase ripple. The phase ripple is proportional to the contents of the

fractional accumulator and is nulled by the fractional compensation charge pump.

The reloading of a new main divider ratio is synchronized to the state of the main divider to avoid introducing a phase disturbance.

Reference divider

The reference divider consists of a divider with programmable values between 4 and 1023 followed by a three bit binary counter. The 3 bit SM (SA) register (see Figure 4) determines which of the 5 output pulses are selected as the main (auxiliary) phase detector input.

Phase detector (see Figure 5)

The reference and main (aux) divider outputs are connected to a phase/frequency detector that controls the charge pump. The pump current is set by an external resistor in conjunction with control bits CP0 and CP1 in the C-word (see Charge Pump table). The dead zone (caused by finite time taken to switch the current sources on or off) is cancelled by forcing the pumps ON for a minimum time at every cycle (backlash time) providing improved linearity.

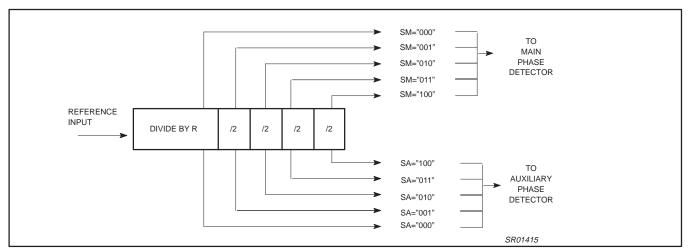


Figure 4. Reference Divider

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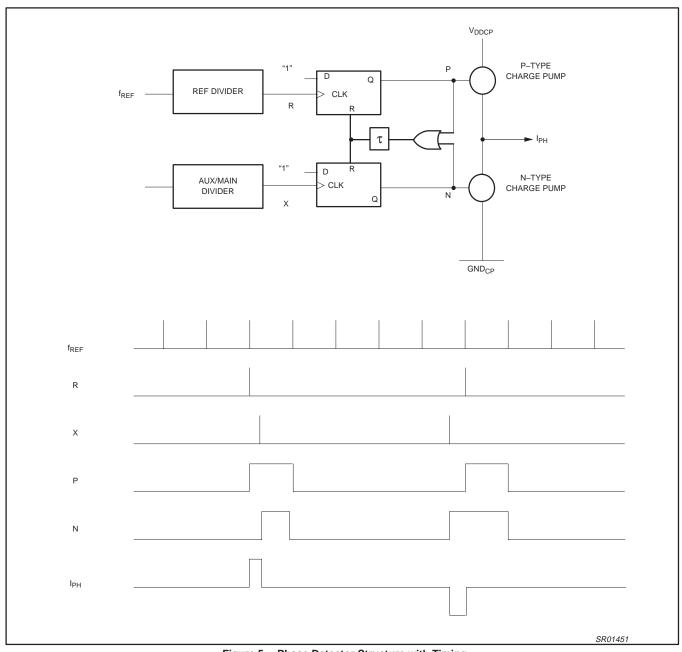


Figure 5. Phase Detector Structure with Timing

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Main Output Charge Pumps and Fractional Compensation Currents (see Figure 6)

The main charge pumps on pins PHP and PHI are driven by the main phase detector and the charge pump current values are determined by the current at pin R_{SET} in conjunction with bits CP0, CP1 in the B-word (see table of charge pump ratios). The fractional compensation is derived from the current at R_{SET}, the contents of the fractional accumulator FRD and by the program value of the FDAC. The timing for the fractional compensation is derived from the main divider. The main charge pumps will enter speed up mode after the A-word is set and strobe goes High. When strobe goes Low, charge pump will exit speed up mode.

Principle of Fractional Compensation

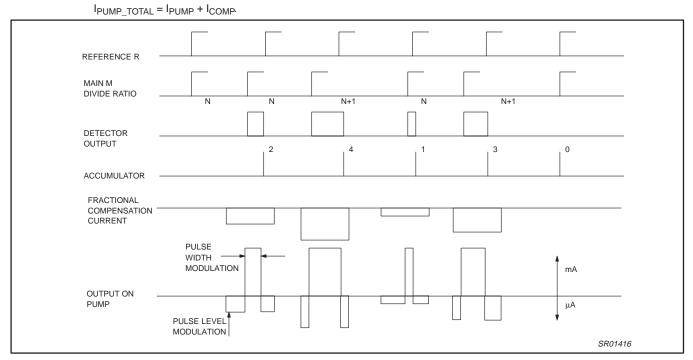
The fractional compensation is designed into the circuit as a means of reducing or eliminating fractional spurs that are caused by the fractional phase ripple of the main divider. If ICOMP is the compensation current and $\ensuremath{I_{\text{PUMP}}}$ is the pump current, then for each charge pump:

The compensation is done by sourcing a small current, I_{COMP} , see Figure 7, that is proportional to the fractional error phase. For proper fractional compensation, the area of the fractional compensation current pulse must be equal to the area of the fractional charge pump ripple. The width of the fractional compensation pulse is fixed to 128 VCO cycles, the amplitude is proportional to the fractional accumulator value and is adjusted by FDAC values (bits FC7-0 in the B-word). The fractional compensation current is derived from the main charge pump in that it follows all the current scaling through external resistor setting, R_{SET}, programming or speed-up operation. For a given charge pump,

 $I_{COMP} = (I_{PUMP} / 128) * (FDAC / 5*128) * FRD$

FRD is the fractional accumulator value.

The target values for FDAC are: 128 for FMOD = 1 (modulo 5) and $80 \text{ for FMOD} = 0 \pmod{8}$.



NOTE: For a proper fractional compensation, the area of the fractional compensation current pulse must be equal to the area of the charge pump ripple output. Figure 6. Waveforms for NF = 2 Modulo 5 \rightarrow fraction = $^{2}/_{5}$

FMOD MAIN DIVIDER FRACTIONAL f_{RF} 1930.140 MHz N = 8042 ACCUMULATOR 240.016 kHz **ICOME** LOOP FILTER f_{REF} & VCO SR01682

Figure 7. Current Injection Concept

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Charge pump currents

CP0	I _{PHP}	I _{PHP-SU}
0	3xI _{SET}	15xl _{SET}
1	1xl _{SET}	5xl _{SET}

NOTES:

- I_{SET}=V_{SET}/R_{SET}: bias current for charge pumps.
 I_{PHP}-SU is the total current at pin PHP during speed up condition.

Lock Detect

The output LOCK maintains a logic '1' when the auxiliary phase detector ANDed with the main phase detector indicates a lock condition. The lock condition for the main and auxiliary synthesizers is defined as a phase difference of less than ± 1 period of the frequency at the input REFin+, -. One counter can fulfill the lock condition when the other counter is powered down. Out of lock (logic '0') is indicated when both counters are powered down.

Power-down mode

The power-down signal can be either hardware (PON) or software (PD). The PON signal is exclusively ORed with the PD bits in B-word. If PON = 0, then the part is powered up when PD = 1. PONcan be used to invert the polarity of the software bit PD. When the synthesizer is reactivated after power-down, the main and reference dividers are synchronized to avoid possibility of random phase errors on power-up.

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Serial programming bus

The serial input is a 3-wire input (CLOCK, STROBE, DATA) to program all counter divide ratios, fractional compensation DAC, selection and enable bits. The programming data is structured into 24 bit words; each word includes 2 or 3 address bits. Figure 8 shows the timing diagram of the serial input. When the STROBE goes active HIGH, the clock is disabled and the data in the shift register remains unchanged. Depending on the address bits, the

data is latched into different working registers or temporary registers. In order to fully program the synthesizer, 3 words must be sent: C, B, and A. Table 1 shows the format and the contents of each word. The D word is normally used for testing purposes. When sending the B-word, data bits FC7–0 for the fractional compensation DAC are not loaded immediately. Instead they are stored in temporary registers. Only when the A-word is loaded, these temporary registers are loaded together with the main divider ratio.

Serial bus timing characteristics. See Figure 8.

 $V_{DD} = V_{DDCP}$ =+3.0V; T_A = +25°C unless otherwise specified.

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
Serial progra	mming clock; CLK	•	•		
t _r	Input rise time	-	10	40	ns
t _f	Input fall time	_	10	40	ns
T _{cy}	Clock period	100	-	-	ns
Enable progra	amming; STROBE		•		
t _{START}	Delay to rising clock edge	40	_	_	ns
t _W	Minimum inactive pulse width	1/f _{COMP}	-	-	ns
t _{SU;E}	Enable set-up time to next clock edge	20	-	-	ns
Register seria	al input data; DATA	•	•		
t _{SU;DAT}	Input data to clock set-up time	20	_	_	ns
t _{HD;DAT}	Input data to clock hold time	20	_	-	ns

Application information

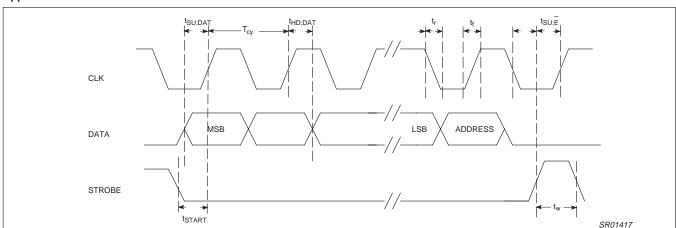


Figure 8. Serial Bus Timing Diagram

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Data format

Table 1. Format of programmed data

ĺ	LAST IN		MSB SERIAL PROGRAMMING FORMAT								
I	p23	p22	p21	p20	/	/	p1	р0			

Table 2. A word, length 24 bits

LAST	IN					MSB															LSB	FIR	ST IN
Addr	ess	fmod Fractional-N Main Divider ratio									Sp	oare											
0	0	FM	NF2	NF1	NF0	N15	N14	N13	N12	N11	N10	N9	N8	N7	N6	N5	N4	N3	N2	N1	N0	SP1	SP2
Default: 0 0 1 0 0 0					0	1	0	0	0	1	0	0	0	1	1	0	0	0	0	0	0		
A wor	d sele	ct			Fixed	Fixed to 00.																	
Fracti	onal M	1odulus	selec	t	FM 0	FM 0 = modulo 8, 1 = modulo 5.																	
Fracti	Fractional-N Increment NF					NF20 Fractional N Increment values 000 to 111.																	
N-Div	N-Divider No.					NON15, Main divider values 512 to 65535 allowed for divider ratio.																	

Table 3. B word, length 24 bits

Addr	ess			F	REFE	RENC	E DI\	/IDER	1			LOCK	PD	СР	FF	RACT	ONA	L COI	MPEN	SATIO	ON DA	C	SPARE
0	1	R9	R8	R7	R6	R5	R4	R3	R2	R1	R0	LO	MAIN	CP0	FC7	FC6	FC5	FC4	FC3	FC2	FC1	FC0	SP3
Defa	ult:	0	0	0	1	0	1	0	0	0	1	0	0	0	0	1	0	1	0	0	0	0	0
B wo	rd sel	ect			Fixed	d to 0°	1																
R-Div	/ider			R0R9, Reference divider values 4 to 1023 allowed for divider ration.																			
Char Ratio		тр си	current CP0: Charge pump current ratio, see table of charge pump currents.																				
Lock	detec	t outp	out		1 N	1ain Ic	ck de	tect s	ignal	prese	nt at t	he LOC he LOC le, the lo	K pin (c	pen d	raín).								
Powe	er dow	/n	Main = 1: power to main divider, reference divider, main charge pumps, Main = 0 to power down.																				
Fract	ional	Comp	Compensation FC70 Fractional Compensation charge pump current DAC, values 0 to 255.																				

Table 4. D word, length 24 bits

<i>-</i>	Address SYNTHESIZER BITS				ST.							SYN.	THES	IZER 1	ΓEST	BITS							
1	1	0	-	-	-	-	-	Tspu	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
	Default:		0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Тѕрі	Tspu: Speed up = 1 Forces the main charge pumps in speed-up mode all the time. NOTE: All test bits must be set to 0 for normal operation.																						

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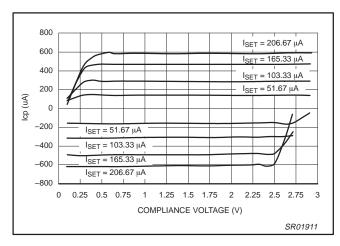


Figure 9. Php Charge Pump Output vs. I_{SET} (CP = 0, TEMP = 25°C)

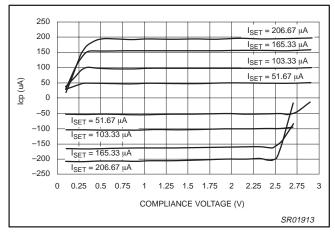


Figure 11. Php Charge Pump Output vs. I_{SET} (CP = 1; TEMP = 25°C)

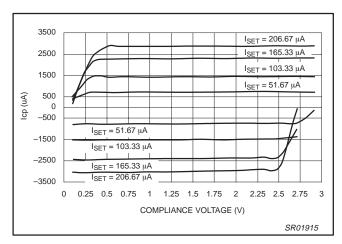


Figure 13. Php-su Charge Pump Output vs. I_{SET} (CP = 0; TEMP = 25°C)

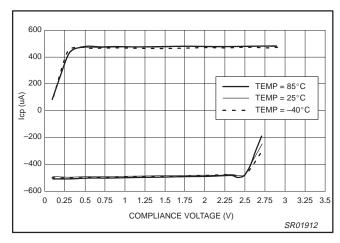


Figure 10. Php Charge Pump Output vs. Temperature (CP = 0; V_{DD} = 3.0 V; I_{SET} = 165.33 μA)

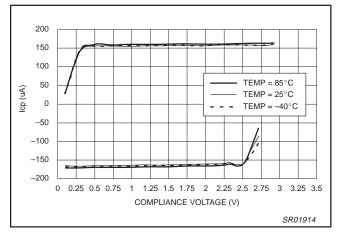


Figure 12. Php Charge Pump Output vs. Temperature (CP = 1; V_{DD} = 3.0 V; I_{SET} = 165.33 μ A)

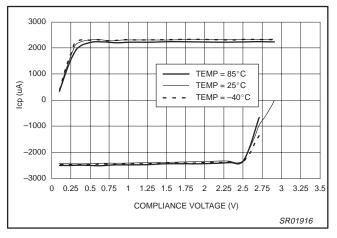


Figure 14. Php-su Charge Pump Output vs. Temperature (CP = 0; V_{DD} = 3.0 V; I_{SET} = 165.33 μ A)

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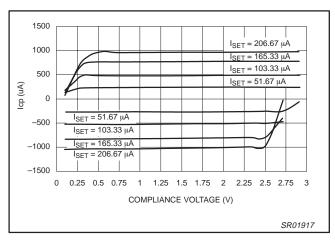


Figure 15. Php-su Charge Pump Output vs. I_{SET} (CP = 1; TEMP = 25°C)

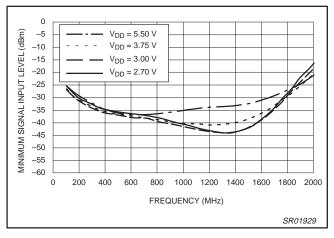


Figure 17. Main Divider Input Sensitivity vs. Frequency and Supply Voltage (TEMP = 25°C)

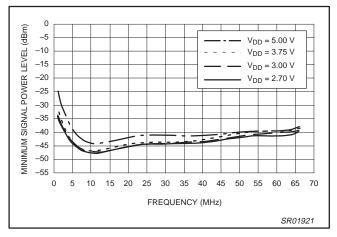


Figure 19. Reference Divider Input Sensitivity vs. Frequency and Supply Voltage (TEMP = 25°C)

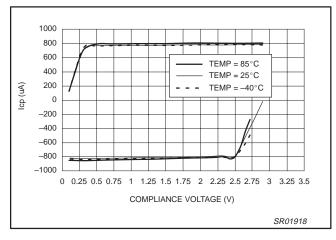


Figure 16. Php-su Charge Pump Output vs. Temperature (CP = 1; V_{DD} = 3.0 V; I_{SET} = 165.33 μ A)

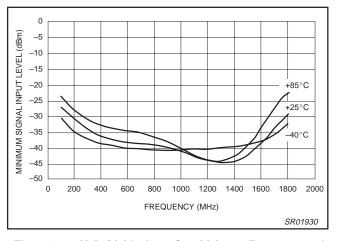


Figure 18. Main Divider Input Sensitivity vs. Frequency and Temperature ($V_{DD} = 3.00 \text{ V}$)

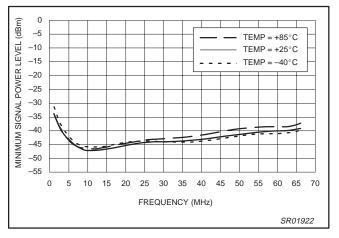


Figure 20. Reference Divider Input Sensitivity vs. Frequency and Temperature ($V_{DD} = 3.00 \text{ V}$)

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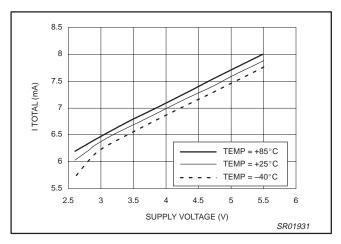


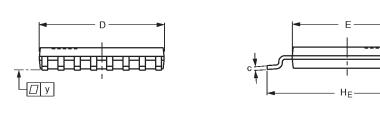
Figure 21. Current Supply Over V_{DD}

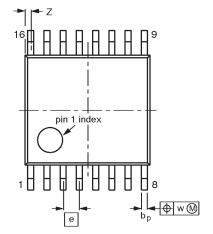
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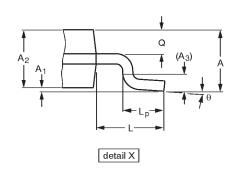
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TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1









DIMENSIONS (mm are the original dimensions)

UNIT	A max.	Α1	A ₂	A ₃	рb	c	D ⁽¹⁾	E ⁽²⁾	Φ	HE	٦	Lp	Ø	ν	w	у	Z ⁽¹⁾	θ
mm	1.10	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1.0	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT403-1		MO-153			-94-07-12 95-04-04

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NOTES

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Data sheet status

Data sheet status	Product status	Definition [1]
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Date of release: 04-99

Document order number: 9397 750 05745

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